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| Notice of References Cited | Application/Control No. 10/635,920 | Applicant(s)/Patent Under Reexamination SWAINE ET AL. | |
| | Examiner Emerson C. Puente | Art Unit 2113 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,031,847 | 02-2000 | Collins et al. | 370/508 |
| * | B | US-5,983,379 | 11-1999 | Warren, Robert | 714/727 |
| * | C | US-5,870,541 | 02-1999 | Tamura, Toshinori | 714/47 |
| * | D | US-6,145,099 | 11-2000 | Shindou, Keisuke | 714/37 |
| * | E | US-6,662,347 | 12-2003 | Wong, Kelvin | 716/4 |
| * | F | US-6,687,811 | 02-2004 | Yamada, Akira | 712/227 |
| * | G | US-7,007,205 | 02-2006 | Yeager et al. | 714/45 |
| * | H | US-7,003,699 | 02-2006 | Swaine et al. | 714/30 |
| * | I | US-6,687,860 | 02-2004 | Iijima et al. | 714/718 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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